

- 6.2 GaAs, at $T = 300$ K, is uniformly doped with acceptor impurity atoms to a concentration of $N_a = 2 \times 10^{16} \text{ cm}^{-3}$. Assume an excess carrier lifetime of 5×10^{-7} s.
- (a) Determine the electron-hole recombination rate if the excess electron concentration is $\delta n = 5 \times 10^{14} \text{ cm}^{-3}$. (b) Using the results of part (a), what is the lifetime of holes?

➤ First, find the electron concentration at thermal equilibrium.

$$\text{Table B.4, } n_i = 1.8 \times 10^6 \text{ \# / cm}^3$$

$$\text{Since } N_a \gg n_i, \rho_0 \approx N_a = 2 \times 10^{16} \text{ \# / cm}^3$$

$$\text{Per (4.43), } n_0 = \frac{n_i^2}{\rho_0} = \frac{(1.8 \times 10^6)^2}{2 \times 10^{16}} \Rightarrow \underline{\underline{n_0 = 1.62 \times 10^{-4} \text{ \# / cm}^3}}$$

$$\text{a) Per (6.14), } R_n' = R_p' = \frac{\delta n(t)}{\tau_{p0}} = \frac{5 \times 10^{14} \text{ cm}^{-3}}{5 \times 10^{-7} \text{ s}}$$

$$\underline{\underline{R_n' = R_p' = 1 \times 10^{21} \frac{\text{\#}}{\text{cm}^3 \text{ s}}}}$$

$$\text{b) Per (6.35), } R_p = \frac{p}{\tau_{pt}} = \frac{n}{\tau_{nt}}$$

$$\tau_{pt} = \frac{\tau_{nt}}{n} p \quad \text{for minority carriers}$$

$$\tau_{nt} \approx \tau_{n0} = 5 \times 10^{-7} \text{ s}$$

$$n \approx n_0 = 1.62 \times 10^{-4} \text{ \# / cm}^3$$

$$p \approx \rho_0 = 2 \times 10^{16} \text{ \# / cm}^3$$

$$\tau_{pt} = \frac{5 \times 10^{-7}}{1.62 \times 10^{-4}} (2 \times 10^{16}) \Rightarrow \underline{\underline{\tau_{pt} = 6.173 \times 10^{13} \text{ s}}}$$

⇒ long time as there are many many more holes than electrons.